

Notice of References Cited	Application/Control No. 10/783,195		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Thao X. Le		Art Unit 2814	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0102551	06-2003	Kikuchi, Hidekazu	257/701
*	B	US-6,605,549	08-2003	Leu et al.	438/758
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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